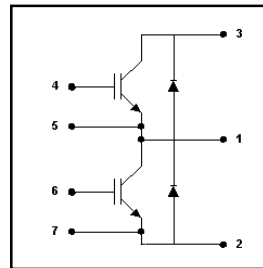


Features

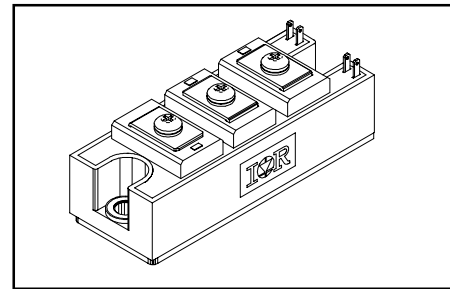
- Generation 4 IGBT technology
- UltraFast: Optimized for high operating frequencies 8-40 kHz in hard switching, >200 kHz in resonant mode
- Very low conduction and switching losses
- HEXFRED™ antiparallel diodes with ultra- soft recovery
- Industry standard package
- UL approved

Benefits

- Increased operating efficiency
- Direct mounting to heatsink
- Performance optimized for power conversion: UPS, SMPS, Welding
- Lower EMI, requires less snubbing



$V_{CES} = 1200V$
 $V_{CE(on) typ.} = 2.4V$
@ $V_{GE} = 15V, I_C = 100A$



Absolute Maximum Ratings

	Parameter	Max.	Units
V_{CES}	Collector-to-Emitter Voltage	1200	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	100	A
I_{CM}	Pulsed Collector Current ①	200	
I_{LM}	Peak Switching Current ②	200	
I_{FM}	Peak Diode Forward Current	200	
V_{GE}	Gate-to-Emitter Voltage	± 20	V
V_{ISOL}	RMS Isolation Voltage, Any Terminal To Case, $t = 1 \text{ min}$	2500	
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	520	W
$P_D @ T_C = 85^\circ C$	Maximum Power Dissipation	270	
T_J	Operating Junction Temperature Range	-40 to +150	$^\circ C$
T_{STG}	Storage Temperature Range	-40 to +125	

Thermal / Mechanical Characteristics

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case - IGBT	—	0.24	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case - Diode	—	0.35	
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink - Module	0.1	—	
	Mounting Torque, Case-to-Heatsink	—	4.0	N·m
	Mounting Torque, Case-to-Terminal 1, 2 & 3 ③	—	3.0	
	Weight of Module	200	—	g

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	1200	—	—	V	$V_{GE} = 0V, I_C = 1mA$
$V_{CE(on)}$	Collector-to-Emitter Voltage	—	2.4	2.9		$V_{GE} = 15V, I_C = 100A$
		—	2.2	—		$V_{GE} = 15V, I_C = 100A, T_J = 125^\circ\text{C}$
$V_{GE(th)}$	Gate Threshold Voltage	3.0	—	6.0		$I_C = 1.25mA$
$\Delta V_{GE(th)}/\Delta T_J$	Temperature Coeff. of Threshold Voltage	—	-11	—	mV/ $^\circ\text{C}$	$V_{CE} = V_{GE}, I_C = 1.25mA$
g_{fe}	Forward Transconductance ④	—	136	—	S	$V_{CE} = 25V, I_C = 100A$
I_{CES}	Collector-to-Emitter Leaking Current	—	—	1.0	mA	$V_{GE} = 0V, V_{CE} = 1200V$
		—	—	10		$V_{GE} = 0V, V_{CE} = 1200V, T_J = 125^\circ\text{C}$
V_{FM}	Diode Forward Voltage - Maximum	—	3.3	4.0	V	$I_F = 100A, V_{GE} = 0V$
		—	3.2	—		$I_F = 100A, V_{GE} = 0V, T_J = 125^\circ\text{C}$
I_{GES}	Gate-to-Emitter Leakage Current	—	—	250	nA	$V_{GE} = \pm 20V$

Dynamic Characteristics - $T_J = 125^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
Q_g	Total Gate Charge (turn-on)	—	830	1245	nC	$V_{CC} = 400V$
Q_{ge}	Gate - Emitter Charge (turn-on)	—	140	210		$I_C = 124A$
Q_{gc}	Gate - Collector Charge (turn-on)	—	275	412		$T_J = 25^\circ\text{C}$
$t_{d(on)}$	Turn-On Delay Time	—	172	—	ns	$R_{G1} = 15\Omega, R_{G2} = 0\Omega,$
t_r	Rise Time	—	141	—		$I_C = 100A$
$t_{d(off)}$	Turn-Off Delay Time	—	435	—		$V_{CC} = 720V$
t_f	Fall Time	—	343	—		$V_{GE} = \pm 15V$
E_{on}	Turn-On Switching Energy	—	14	—	mJ	
$E_{off(1)}$	Turn-Off Switching Energy	—	21	—		
$E_{ts(1)}$	Total Switching Energy	—	35	52		
C_{ies}	Input Capacitance	—	18672	—	pF	$V_{GE} = 0V$
C_{oes}	Output Capacitance	—	830	—		$V_{CC} = 30V$
C_{res}	Reverse Transfer Capacitance	—	161	—		$f = 1\text{ MHz}$
t_{rr}	Diode Reverse Recovery Time	—	149	—	ns	$I_C = 100A$
I_{rr}	Diode Peak Reverse Current	—	104	—	A	$R_{G1} = 15\Omega$
Q_{rr}	Diode Recovery Charge	—	7664	—	μC	$R_{G2} = 0\Omega$
$di_{(rec)M}/dt$	Diode Peak Rate of Fall of Recovery During t_b	—	1916	—	A/ μs	$V_{CC} = 720V$ $di/dt > 1300A/\mu\text{s}$

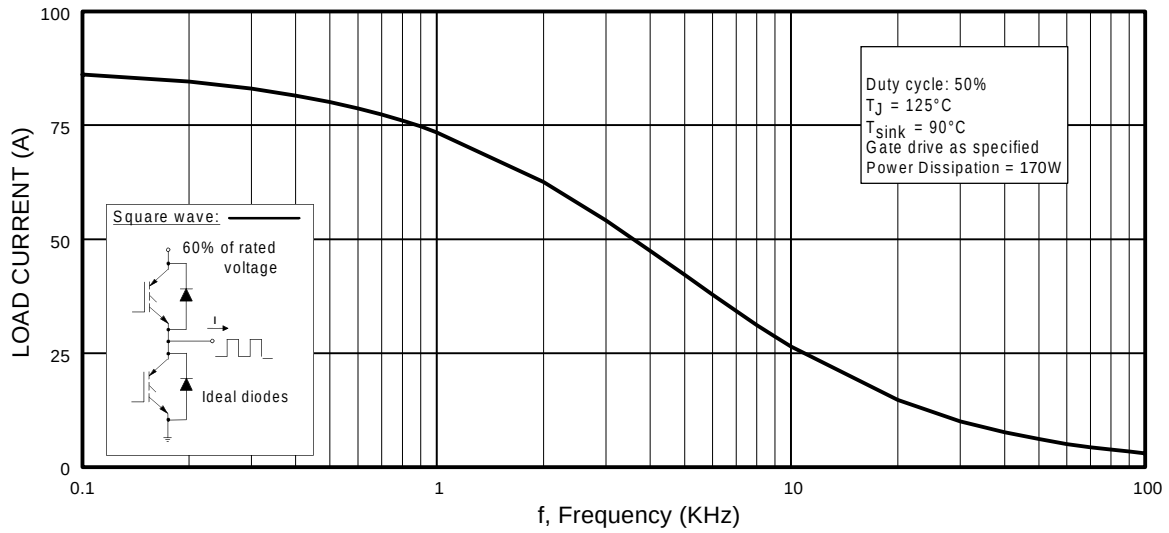


Fig. 1 - Typical Load Current vs. Frequency
(Load Current = I_{RMS} of fundamental)

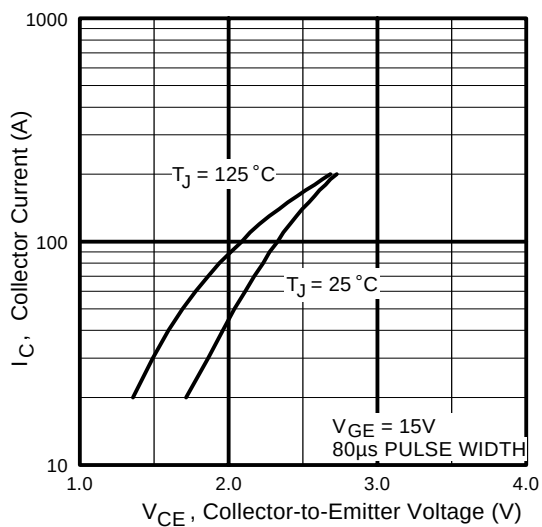


Fig. 2 - Typical Output Characteristics

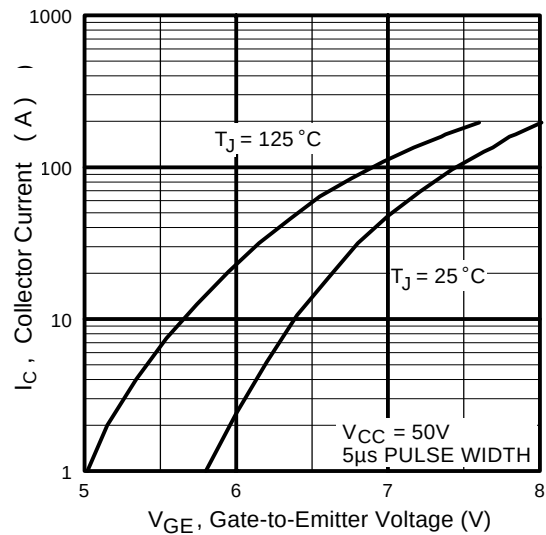


Fig. 3 - Typical Transfer Characteristics

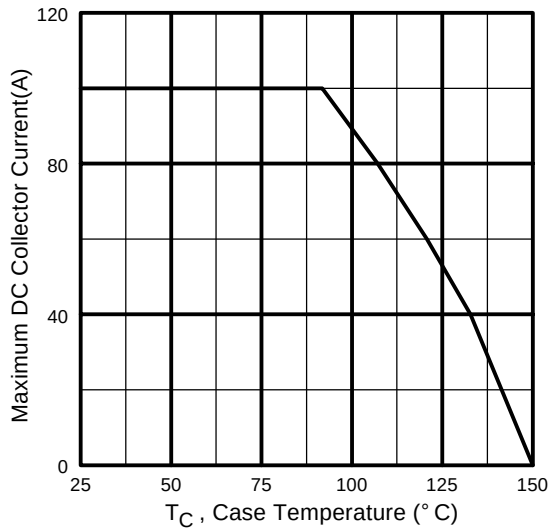


Fig. 4 - Maximum Collector Current vs. Case Temperature

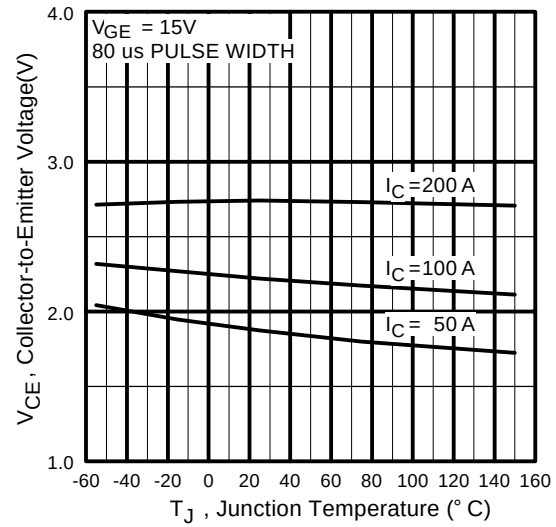


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

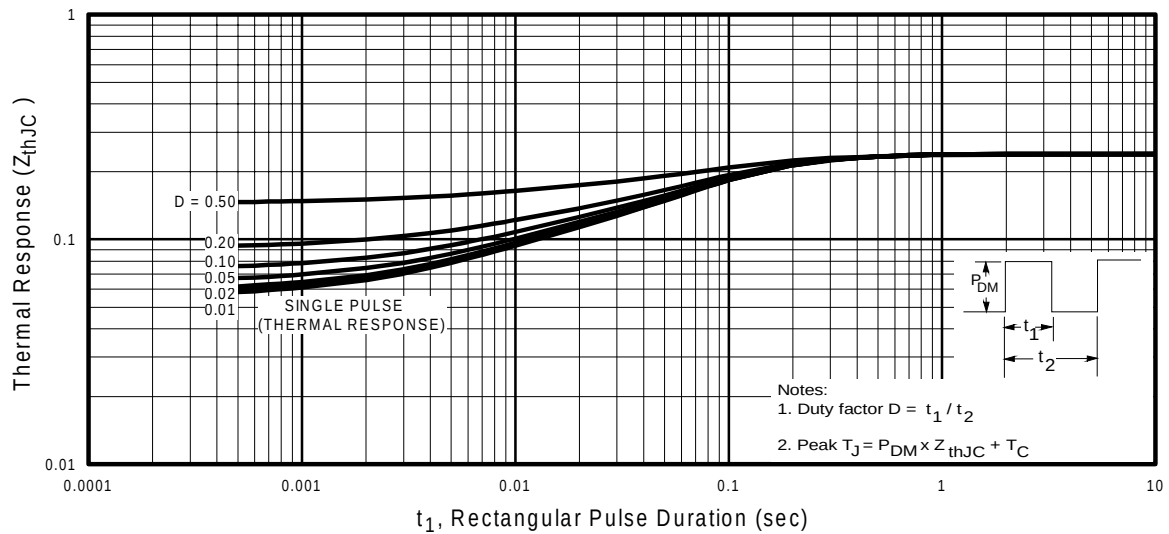


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

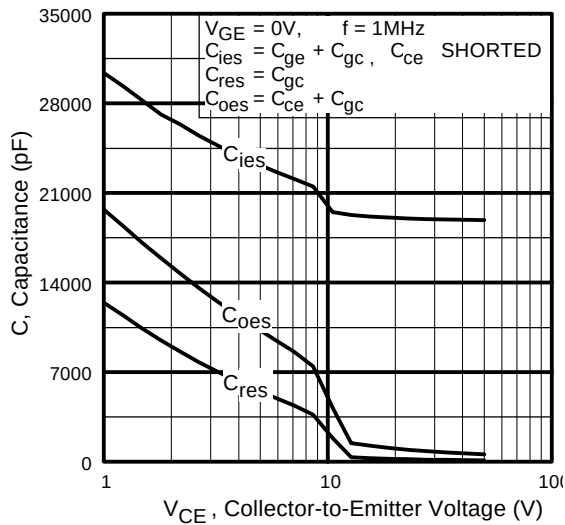


Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage

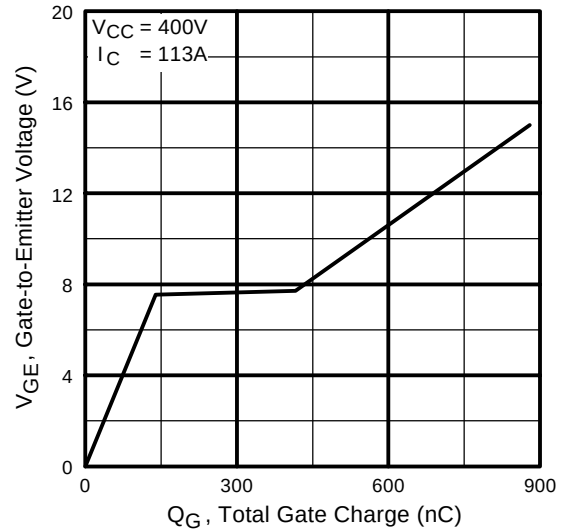


Fig. 8 - Typical Gate Charge vs. Gate-to-Emitter Voltage

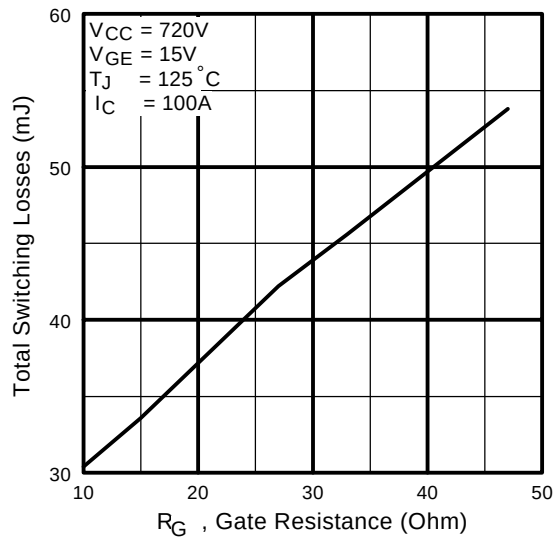


Fig. 9 - Typical Switching Losses vs. Gate Resistance

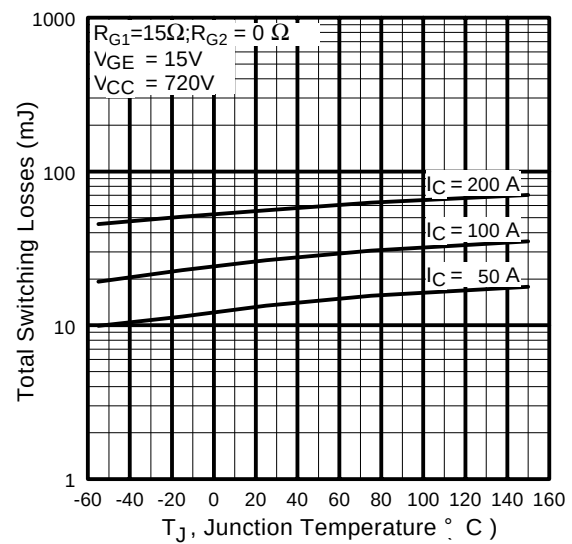


Fig. 10 - Typical Switching Losses vs. Junction Temperature

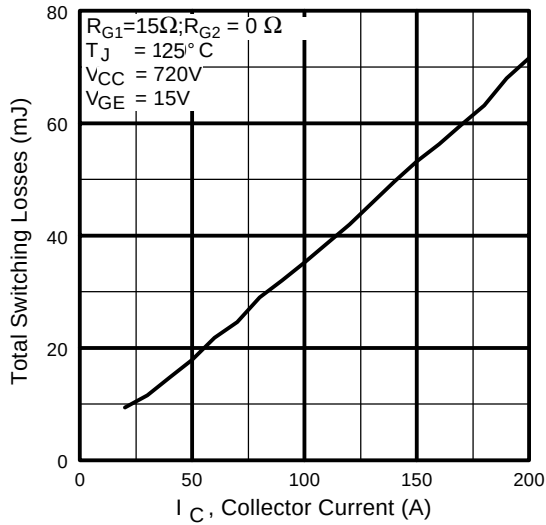


Fig. 11 - Typical Switching Losses vs. Collector Current

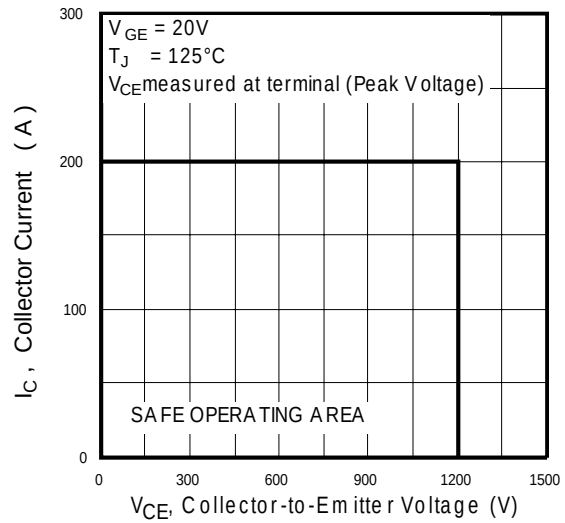


Fig. 12 - Reverse Bias SOA

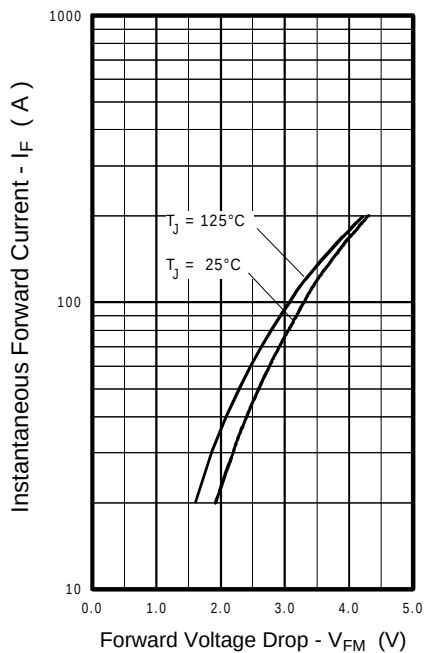


Fig. 13 - Typical Forward Voltage Drop vs. Instantaneous Forward Current

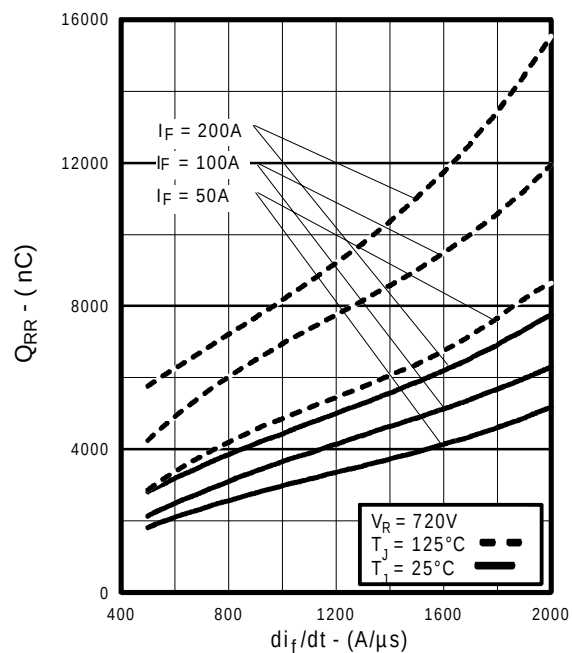


Fig. 14 - Typical Stored Charge vs. di_f/dt

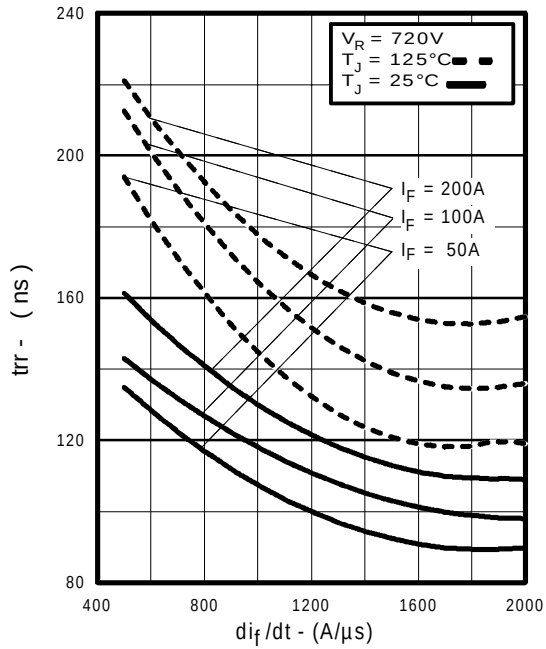


Fig. 15 - Typical Reverse Recovery vs. di_F/dt

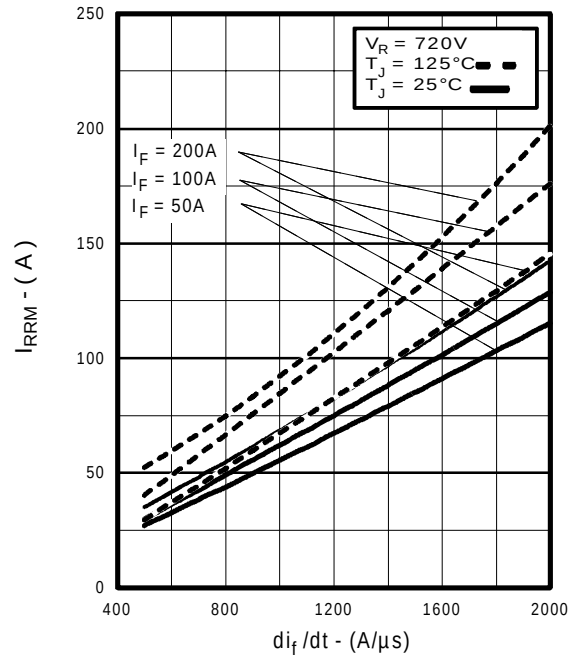


Fig. 16 - Typical Recovery Current vs. di_F/dt

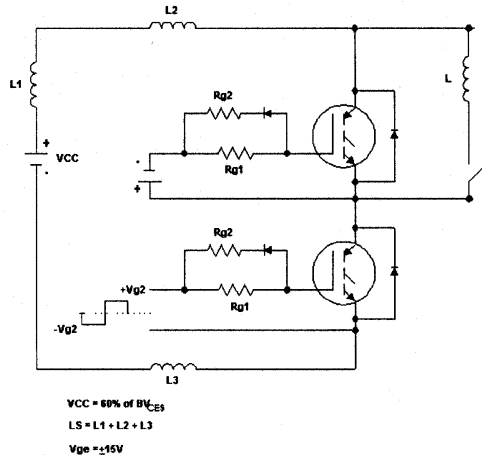


Fig. 17a - Test Circuit for Measurement of I_{LM} , E_{on} , $E_{off}(\text{diode})$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

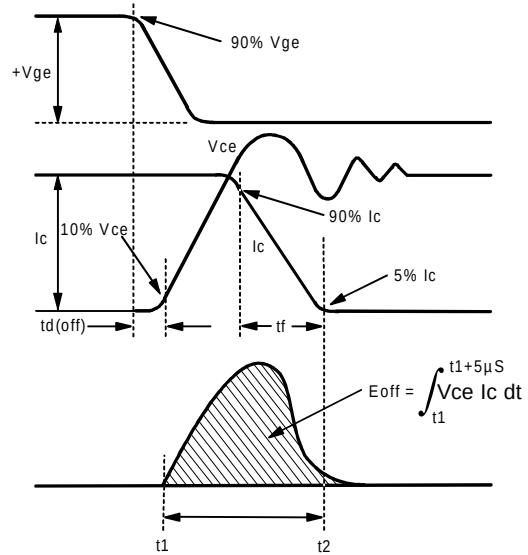


Fig. 17b - Test Waveforms for Circuit of Fig. 18a, Defining E_{off} , $t_{d(off)}$, t_f

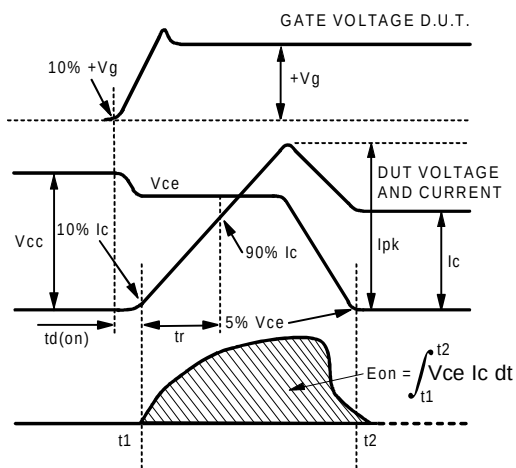


Fig. 17c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

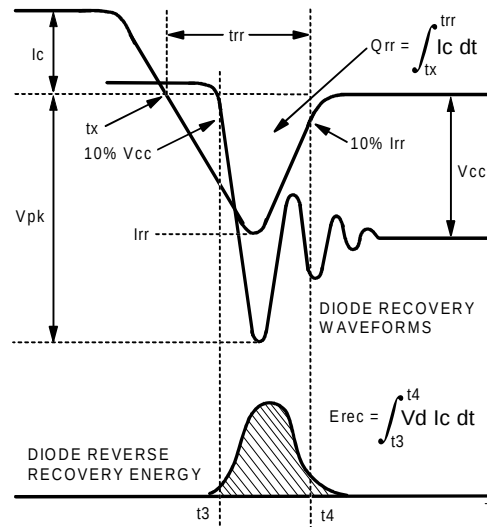


Fig. 17d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

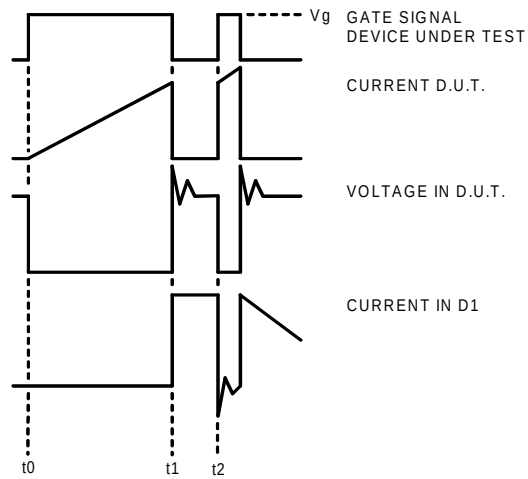


Figure 17e. Macro Waveforms for Figure 18a's Test Circuit

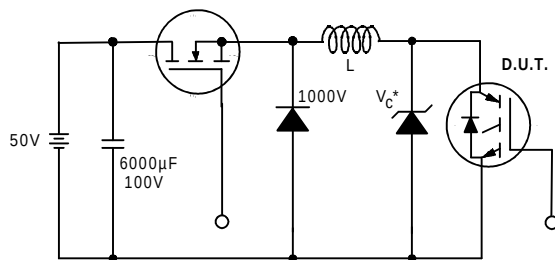


Figure 18. Clamped Inductive Load Test Circuit

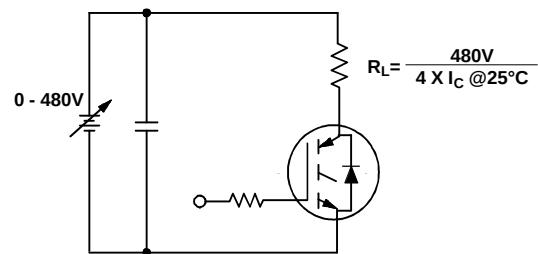


Figure 19. Pulsed Collector Current Test Circuit

International
IOR Rectifier

- ① Repetitive rating; $V_{GE} = 20V$, pulse width limited by max. junction temperature.
- ② See fig. 17
- ③ For screws M5x0.8
- ④ Pulse width 50 μs ; single shot.

Technical drawings of the 1000mAh 3.7V Li-ion battery pack, showing dimensions in millimeters (inches).

Top Left View (Side View):

- Dimensions: 2X 23.5 (.925) / 22.5 (.886), 19.5 (.768) / 18.5 (.728), 9.0 (.354) / 7.0 (.275), 47.5 (1.870) / 46.5 (1.830), 25 (.984) / 22 (.866).
- Labels: 3X SCREWS M5 X 0.8 LENGTH: 10mm, 4X FAST-ON TAB. 110 2.8 X 0.5, SEE PROFILE.

Top Right View (Top View):

- Dimensions: 29.5 (1.161) / 28.5 (1.122), 32.0 (1.260) / 29.0 (1.142), 36.25 (1.427) / 34.75 (1.368), 9.0 (.354) / 8.0 (.315).

Bottom View (Front View):

- Dimensions: 18.5 (.728) / 17.5 (.689), 17.5 (.689) / 16.5 (.650), 12.46 (.490) / 11.95 (.469), 80.3 (3.161) / 79.7 (3.137), 94.25 (3.705) / 92.75 (3.652), 18.25 (.719) / 17.25 (.679), 4.5 (.177) / 3.5 (.136), 17.5 (.689) / 16.5 (.650), 19.5 (.768) / 18.5 (.728), 25 (.984) / 22 (.866).
- Labels: 2X, Ø6.75 (.266) / Ø6.25 (.246).

Dimensions are shown in millimeters (inches).

Dimensions are shown in millimeters (inches)

International
IOR Rectifier

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IR GERMANY: Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 (0) 6172 96590
IR ITALY: Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 011 451 0111
IR JAPAN: K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo 171 Tel: 81 (0)3 3983 0086
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Data and specifications subject to change without notice. 4/00